Patent Quality Conference

Tuesday, December 13, 2016
8:30 a.m. – 5:00 p.m.
(Madison Auditorium)
Hosted by USPTO, Duke and Santa Clara Law Schools

8:00 – 8:30	Check-in/Reception
Opening Remarks	
8:30 – 8:40	Welcome to USPTO and Conference
Keynote Speaker	**Michelle K. Lee**
8:40 – 8:55	Future Impact of Patent Quality in the Greater IP Community
Part 1. Enhanced Patent Quality Results	
8:55 – 9:25	Clarity of the Record Pilot Results
9:25 – 9:50	Improving Clarity and Reasoning in Office Actions (ICR) Training/STEPP/Use of Artificial Intelligence in Finding Prior Art
9:50 – 10:20	Master Review Form and Quality Metrics Results
10:20 – 10:30	Break
10:30 – 10:50	Topic Submission for Case Studies Results
10:50 – 11:50	Panel Discussion with USPTO and Practitioners: ***Patent Quality in the USPTO – Our next steps!***
11:50 – 1:15	**Lunch**
12:15 – 1:15	**Ethics Presentation** (Application for CLE Credit Submitted to Virginia State Bar)
Part 2. Post Grant Activity	
1:15 – 1:30	Patent Quality and Post-Grant Activities
1:30 – 1:50	Effect of Patent Quality in U.S. Courts
1:50 – 2:45	Panel Discussion with Judges: ***Patent Quality and Its Impact in the U.S.* Courts**
2:45 – 2:55	Break
Part 3. International and Stakeholder Cooperation	
2:55 – 3:40	Panel Discussion with International Stakeholders: ***International Quality Efforts***
3:40 – 3:45	Break
3:45 – 4:45	Panel Discussion with Stakeholders: ***What can Applicants do to enhance Patent Quality?***
Closing Remarks	
4:45 – 5:00	Next Steps of Enhancing Patent Quality